

# SIC MOSFET

#### CoolSiC™ MOSFET 650 V G2

Built on Infineon's robust 2<sup>nd</sup> generation Silicon Carbide trench technology, the 650 V CoolSiC™ MOSFET delivers unparalleled performance, superior reliability, and great ease of use. It enables cost effective, highly efficient, and simplified designs to fulfill the ever-growing system and market needs.

# PG-LHSOF-4

#### **Features**

- Ultra-low switching losses
- Benchmark gate threshold voltage,  $V_{GS(th)} = 4.5 \text{ V}$
- Robust against parasitic turn-on even with 0 V turn-off gate voltage
- Flexible driving voltage and compatible with bipolar driving scheme
- Robust body diode operation under hard commutation events
- .XT interconnection technology for best-in-class thermal performance

#### **Benefits**

- · Enables high efficiency and high power density designs
- Facilitates great ease of use and integration
- Provides the best price performance ratio compared to Industry's most ambitious roadmaps
- · Reduces the size, weight and bill of materials of the systems
- Enhances system robustness and reliability

# Potential applications

- SMPS
- Solar PV inverters
- · Energy storage and battery formation
- UPS
- EV charging infrastructure
- Motor drives

#### **Product validation**

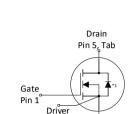
Fully qualified according to JEDEC for Industrial Applications

Please note: The source and driver source pins are not exchangeable. Their exchange might lead to malfunction.



Parameter	Value	Unit
$V_{\rm DSS}$ over full $T_{\rm j,range}$	650	V
$R_{\mathrm{DS(on),typ}}$	20	mΩ
R <sub>DS(on),max</sub>	24	mΩ
$Q_{G,typ}$	57	nC
I <sub>D,pulse</sub>	288	А
Q <sub>oss</sub> @ 400 V	108	nC
E <sub>oss</sub> @ 400 V	14.7	μЈ

Type/Ordering Code	Package	Marking	Related Links
IMTA65R020M2H	PG-LHSOF-4	65R020M2	see Appendix A









#### Public

# CoolSiC™ MOSFET 650 V G2 IMTA65R020M2H



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# 1 Maximum ratings

at  $T_i = 25$  °C, unless otherwise specified.

Note: for optimum lifetime and reliability, Infineon recommends operating conditions that do not exceed 80% of the maximum ratings stated in this datasheet.

Table 2 Maximum ratings

Parameter	Symbol	,	Value	S	Unit	Note / Test Condition
raiailletei	Symbol	Min.	Тур.	Мах.	Oille	Note/ Test Condition
Continuous DC drain current <sup>1)</sup>	I <sub>DDC</sub>	-	-	77 64	А	$T_c = 25 ^{\circ}\text{C}$ $T_c = 100 ^{\circ}\text{C}$
Peak drain current <sup>2)</sup>	I <sub>DM</sub>	-	-	288	А	$T_{\rm c}$ = 25 °C, $V_{\rm GS}$ = 18 V
Avalanche energy, single pulse	E <sub>AS</sub>	-	-	272	mJ	$I_{\rm D}$ = 10.2 A, $V_{\rm DD}$ = 50 V; see table 11
Avalanche energy, repetitive	$E_{AR}$	-	-	1.36	mJ	$I_{\rm D}$ = 10.2 A, $V_{\rm DD}$ = 50 V; see table 11
Avalanche current, single pulse	I <sub>AS</sub>	-	-	10.2	Α	-
MOSFET <i>dv/dt</i> ruggedness	dv/dt	-	-	200	V/ns	V <sub>DS</sub> = 0400 V
Gate source voltage (static) 3)	$V_{GS}$	-7	-	23	V	-
Gate source voltage (transient)	$V_{GS}$	-10	-	25	V	t <sub>p</sub> ≤ 500 ns, duty cycle ≤ 1 %
Power dissipation	$P_{\text{tot}}$	-	-	416	W	T <sub>c</sub> = 25 °C
Storage temperature	$T_{\rm stg}$	-55	-	150	°C	-
Operating junction temperature	T <sub>j</sub>	-55	-	175	°C	-
Mounting torque	-	-	-	-	Ncm	-
Continuous reverse drain current <sup>1)</sup>	I <sub>SDC</sub>	-	-	77 70	А	$V_{\rm GS}$ = 18 V, $T_{\rm c}$ = 25 °C $V_{\rm GS}$ = 0 V, $T_{\rm c}$ = 25 °C
Peak reverse drain current <sup>2)</sup>	I <sub>SM</sub>	-	-	288 88	А	$T_c$ = 25 °C, $t_p$ ≤ 250 ns $T_c$ = 25 °C
Insulation withstand voltage	V <sub>ISO</sub>	-	-	n.a.	V	$V_{\rm rms}$ , $T_{\rm c} = 25 {\rm ^{\circ}C}$ , $t = 1 {\rm min}$

<sup>1)</sup> Limited by  $T_{j,max}$ .

Pulse width  $t_{\text{pulse}}$  limited by  $T_{\text{j,max}}$ .

<sup>3)</sup> The maximum gate-source voltage in the application design should be in accordance to IPC-9592B.



# 2 Thermal characteristics

#### Table 3 Thermal characteristics

Domonostore	Symbol	Values			11:4:4	Note / Test Condition
Parameter		Min.	Тур.	Мах.	Unit	Note/ Test Condition
Thermal resistance, junction - case	$R_{th(j-c)}$	-	-	0.36	°C/W	Not subject to production test. Parameter verified by design/characterization according to JESD51-14.
Soldering temperature, reflow soldering allowed	$T_{\rm sold}$	-	-	260	°C	reflow MSL1



# 3 Operating range

## Table 4 Operating range

Parameter	Symbol	,	Values Unit N		Unit	Note/ Test Condition
raiametei	Syllibot	Min.	Тур.	Мах.	UIIIL	Note/ Test Condition
Recommended turn-on voltage	$V_{GS(on)}$	-	18	-	V	-
Recommended turn-off voltage	$V_{GS(off)}$	-	0	-	V	-



## 4 Electrical characteristics

at  $T_i$  = 25 °C, unless otherwise specified

#### Table 5 Static characteristics

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Parameter	Symbol		Values			Note / Test Condition	
raiailletei	Syllibot	Min.	Тур.	Мах.	Unit	Note/ Test Condition	
Drain-source voltage	V <sub>DSS</sub>	650	-	-	V	$V_{\rm GS} = 0 \text{ V}, I_{\rm D} = 0.95 \text{ mA}$	
Gate threshold voltage <sup>4)</sup>	$V_{\rm GS(th)}$	3.5	4.5	5.6	V	$V_{\rm DS} = V_{\rm GS}, I_{\rm D} = 9.5 \rm mA$	
Zero gate voltage drain current	I <sub>DSS</sub>	-	1 3	75 -	μΑ	$V_{\rm DS} = 650 \text{ V}, V_{\rm GS} = 0 \text{ V}, T_{\rm j} = 25 \text{ °C}$ $V_{\rm DS} = 650 \text{ V}, V_{\rm GS} = 0 \text{ V}, T_{\rm j} = 175 \text{ °C}$	
Gate-source leakage current	I <sub>GSS</sub>	-	-	100	nA	$V_{GS} = 20 \text{ V}, V_{DS} = 0 \text{ V}$	
Drain-source on-state resistance	R <sub>DS(on)</sub>	-	26 20 18 33	- 24 - -	mΩ	$V_{GS} = 15 \text{ V}, I_D = 46.9 \text{ A}, T_j = 25 \text{ °C}$ $V_{GS} = 18 \text{ V}, I_D = 46.9 \text{ A}, T_j = 25 \text{ °C}$ $V_{GS} = 20 \text{ V}, I_D = 46.9 \text{ A}, T_j = 25 \text{ °C}$ $V_{GS} = 18 \text{ V}, I_D = 46.9 \text{ A}, T_j = 175 \text{ °C}$	
Internal gate resistance	$R_{G,int}$	-	2.5	-	Ω	f= 1 MHz	

<sup>&</sup>lt;sup>4)</sup> Tested after 1 ms pulse at V<sub>GS</sub> = +20 V. "Linear mode" operation is not recommended. For assessment of potential "linear mode" operation, please contact Infineon sales office.

#### Table 6 Dynamic characteristics

External parasitic elements (PCB layout) influence switching behavior significantly. Stray inductances and coupling capacitances must be minimized. For layout recommendations please use provided application notes or contact Infineon sales office.

Parameter	Symbol	Values			Unit	Note/ Test Condition
raiailletei	Syllibot	Min.	Тур.	Мах.	Offic	Note/ Test Condition
Input capacitance	C <sub>iss</sub>	-	2038	-	pF	$V_{\rm GS} = 0 \text{ V}, V_{\rm DS} = 400 \text{ V}, f = 250 \text{ kHz}$
Reverse transfer capacitance	$C_{rss}$	-	11.5	-	pF	$V_{\rm GS} = 0 \text{ V}, V_{\rm DS} = 400 \text{ V}, f = 250 \text{ kHz}$
Output capacitance <sup>5)</sup>	C <sub>oss</sub>	-	151	197	pF	$V_{GS} = 0 \text{ V}, V_{DS} = 400 \text{ V}, f = 250 \text{ kHz}$
Output charge <sup>5)</sup>	$Q_{\rm oss}$	-	108	141	nC	calculation based on C <sub>oss</sub>
Effective output capacitance, energy related <sup>6)</sup>	$C_{ m o(er)}$	-	183	-	pF	$V_{GS} = 0 \text{ V},$ $V_{DS} = 0400 \text{ V}$
Effective output capacitance, time related <sup>7)</sup>	$C_{ m o(tr)}$	-	271	-	pF	$I_{\rm D}$ = constant, $V_{\rm GS}$ = 0 V, $V_{\rm DS}$ = 0400 V
Turn-on delay time	$t_{ m d(on)}$	-	10.3	-	ns	$V_{\rm DD} = 400  \text{V}, \ V_{\rm GS} = 0/18  \text{V},$ $I_{\rm D} = 46.9  \text{A}, \ R_{\rm G,ext} = 1.8  \Omega;$ see table 10
Rise time	t <sub>r</sub>	-	12.0	-	ns	$V_{\rm DD} = 400  \text{V}, \ V_{\rm GS} = 0/18  \text{V},$ $I_{\rm D} = 46.9  \text{A}, \ R_{\rm G,ext} = 1.8  \Omega;$ see table 10



#### Table 6 Dynamic characteristics

External parasitic elements (PCB layout) influence switching behavior significantly. Stray inductances and coupling capacitances must be minimized. For layout recommendations please use provided application notes or contact Infineon sales office.

Parameter	Symbol	Values			Unit	Note / Test Condition
- raidilletei	Syllibot	Min.	Тур.	Мах.	Offic	Note/ Test Condition
Turn-off delay time	$t_{ m d(off)}$	-	19	-	ns	$V_{\rm DD} = 400  \rm V, \ V_{\rm GS} = 0/18  \rm V,$ $I_{\rm D} = 46.9  \rm A, \ R_{\rm G,ext} = 1.8  \Omega;$ see table 10
Fall time	$t_{\rm f}$	-	5.6	-	ns	$V_{\rm DD} = 400  \text{V}, \ V_{\rm GS} = 0/18  \text{V},$ $I_{\rm D} = 46.9  \text{A}, \ R_{\rm G,ext} = 1.8  \Omega;$ see table 10
Turn-ON switching losses <sup>8)</sup>	E <sub>on</sub>	-	59	-	μJ	$V_{\rm DD} = 400 \text{ V}, V_{\rm GS} = 0/18 \text{ V},$ $I_{\rm D} = 46.9 \text{ A}, R_{\rm G,ext} = 1.8 \Omega$
Turn-OFF switching losses <sup>8)</sup>	$E_{ m off}$	-	64	-	μJ	$V_{\rm DD} = 400 \text{ V}, V_{\rm GS} = 0/18 \text{ V},$ $I_{\rm D} = 46.9 \text{ A}, R_{\rm G,ext} = 1.8 \Omega$
Total switching losses <sup>8)</sup>	$E_{tot}$	-	123	-	μJ	$V_{\rm DD} = 400 \text{ V}, V_{\rm GS} = 0/18 \text{ V},$ $I_{\rm D} = 46.9 \text{ A}, R_{\rm G,ext} = 1.8 \Omega$

<sup>5)</sup> Maximum specification is defined by calculated six sigma upper confidence bound

Table 7 Gate charge characteristics

Darameter	Symbol	Values			Unit	Note / Test Condition
Parameter	Syllibot	Min.	Тур.	Мах.	Offic	Note/ Test Condition
Plateau gate to source charge	$Q_{GS(pl)}$	-	15	-	nC	$V_{\rm DD} = 400 \text{ V}, I_{\rm D} = 46.9 \text{ A},$ $V_{\rm GS} = 0 \text{ to } 18 \text{ V}$
Gate to drain charge	$Q_{GD}$	-	10.7	-	nC	$V_{\rm DD} = 400 \text{ V}, I_{\rm D} = 46.9 \text{ A},$ $V_{\rm GS} = 0 \text{ to } 18 \text{ V}$
Total gate charge	$Q_{G}$	_	57	-	nC	$V_{\rm DD} = 400 \text{V}, I_{\rm D} = 46.9 \text{A},$ $V_{\rm GS} = 0 \text{to}  18 \text{V}$

Table 8 Reverse diode characteristics

Parameter	Symbol	Values			Linit	Note/ Test Condition
raiametei	Symbol	Min.	Тур.	Мах.	Unit	Note/ Test Condition
Drain-source reverse voltage	$V_{\rm SD}$	-	4.3	-	V	$V_{\rm GS} = 0 \text{ V}, I_{\rm S} = 46.9 \text{ A}, T_{\rm j} = 25 \text{ °C}$
MOSFET forward recovery time	t <sub>fr</sub>	-	18 13.2	-	ns	$V_{DD} = 400 \text{ V}, I_{S} = 46.9 \text{ A},$ $di_{S}/dt = 1000 \text{ A/}\mu\text{s}; \text{ see table 9}$ $V_{DD} = 400 \text{ V}, I_{S} = 46.9 \text{ A},$ $di_{S}/dt = 4000 \text{ A/}\mu\text{s}; \text{ see table 9}$

 $C_{o(er)}$  is a fixed capacitance that gives the same stored energy as  $C_{oss}$  while  $V_{DS}$  is rising from 0 to 400 V.

<sup>7)</sup>  $C_{o(tr)}$  is a fixed capacitance that gives the same charging time as  $C_{oss}$  while  $V_{DS}$  is rising from 0 to 400 V.

<sup>8)</sup> Values for 4-pin configuration based on TO-263-7 measurements; MOSFET used in half-bridge configuration without external diode



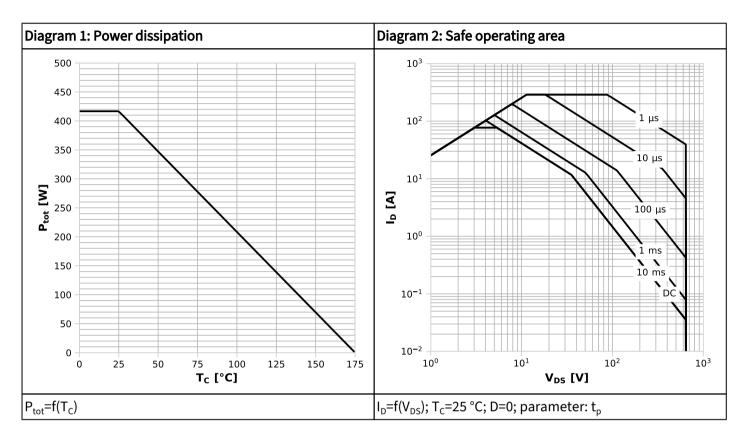
#### Table 8 Reverse diode characteristics

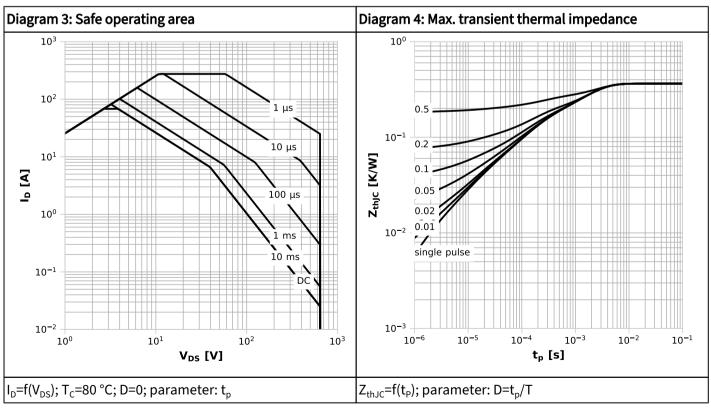
Parameter	Symbol	,	Values			Nieto/Tost Condition
raiailletei	Symbol	Min.	Тур.	Мах.	Unit	Note/ Test Condition
MOSFET forward recovery charge <sup>9)</sup>	$Q_{fr}$	-	110 184	-	nC	$V_{DD} = 400 \text{ V}, I_{S} = 46.9 \text{ A},$ $di_{S}/dt = 1000 \text{ A/}\mu\text{s}; \text{ see table 9}$ $V_{DD} = 400 \text{ V}, I_{S} = 46.9 \text{ A},$ $di_{S}/dt = 4000 \text{ A/}\mu\text{s}; \text{ see table 9}$
MOSFET peak forward recovery current	$I_{frm}$	-	12.2 27.8	-	А	$V_{\rm DD} = 400 \text{V},  I_{\rm S} = 46.9 \text{A},$ $di_{\rm S}/dt = 1000 \text{A}/\mu\text{s};  \text{see table 9}$ $V_{\rm DD} = 400 \text{V},  I_{\rm S} = 46.9 \text{A},$ $di_{\rm S}/dt = 4000 \text{A}/\mu\text{s};  \text{see table 9}$

<sup>9)</sup>  $Q_{\rm fr}$  includes  $Q_{\rm oss}$ 

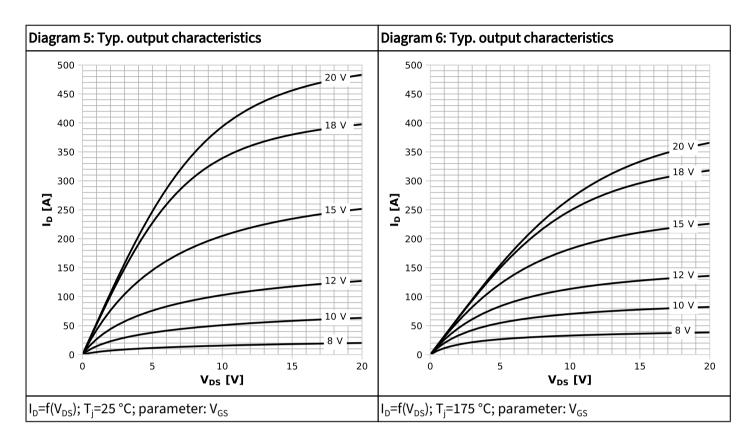


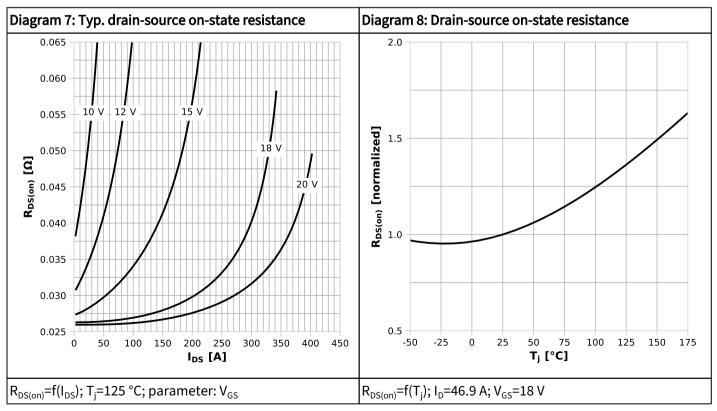
# 5 Electrical characteristics diagrams



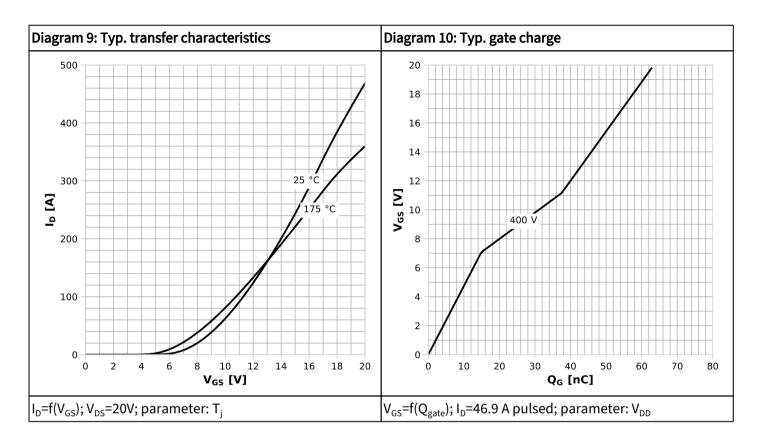


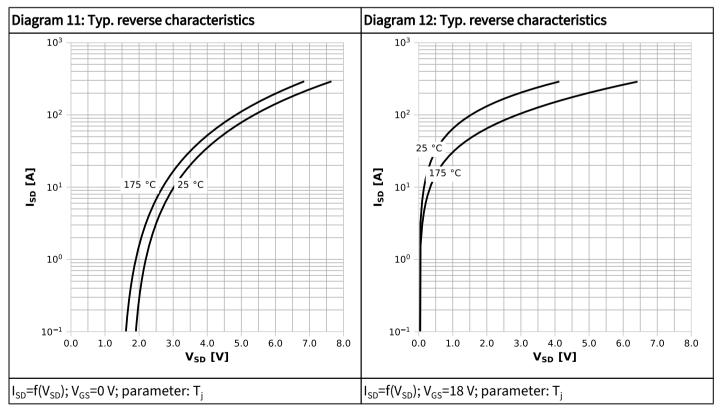




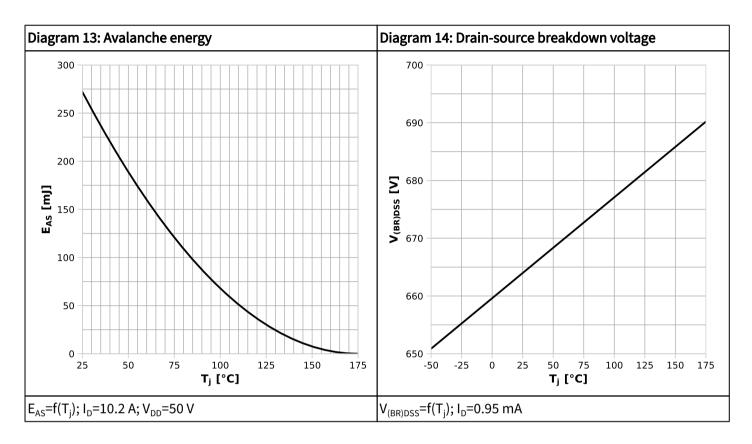


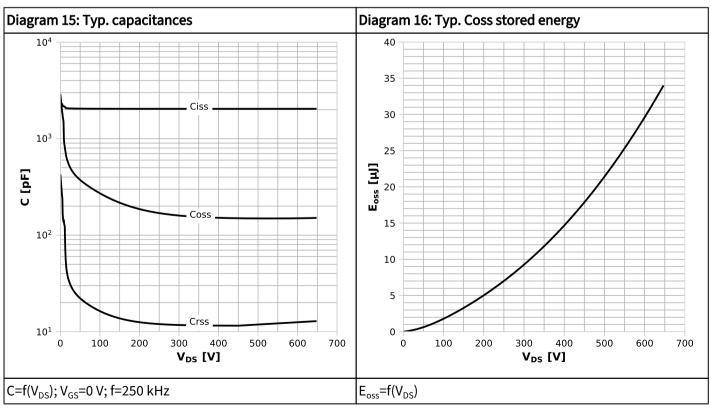




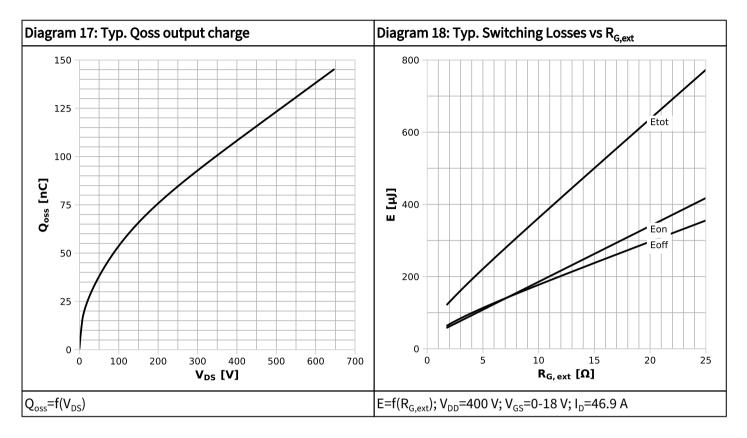


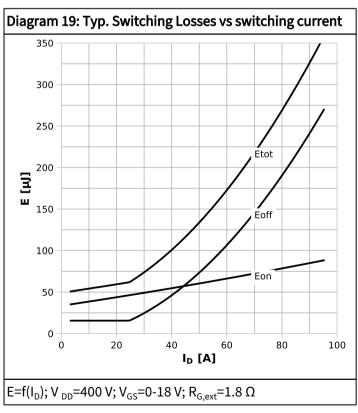














## 6 Test Circuits

Table 9 Body diode characteristics (CoolSiC)

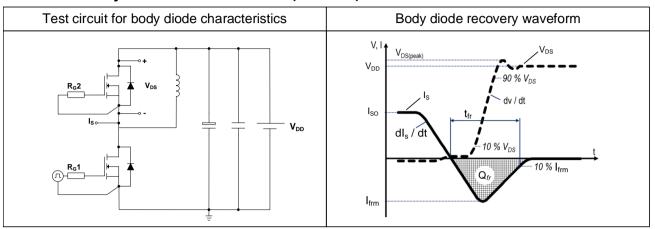


Table 10 Switching times (CoolSiC)

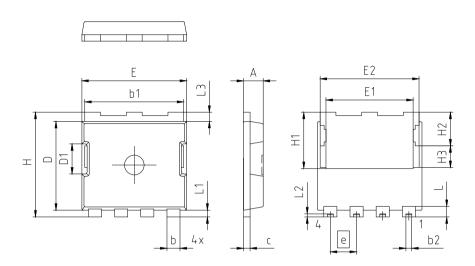


Table 11 Unclamped inductive load





# 7 Package Outlines



PACKAGE - GROUP NUMBER:	PG-LHS	OF-4-U01
DIMENSIONS	MILLIMETERS	
DIMENSIONS	MIN.	MAX.
Α	1.40	1.60
b	0.90	1.10
b1	7.46	7.66
b2	0.42	0.50
С	0.40	0.60
D	6.59	6.99
D1	2.30	
E	7.80	8.20
E1	6.66	
E2	7.56	
е	2.00	
N	4	
Н	7.80	8.20
H1	4.30	
H2	2.57	
Н3	1.65	
L	0.50	1.00
L1	0.51	
L2	0.23	
L3	0.50	0.90

Figure 1 Outline PG-LHSOF-4, dimensions in mm



# 8 Appendix A

#### Table 12 Related Links

- IFX CoolSiC CoolSiC™ MOSFET 650 V G2 Webpage
- IFX CoolSiC CoolSiC™ MOSFET 650 V G2 Application Note
- IFX CoolSiC CoolSiC™ MOSFET 650 V G2 Simulation Model
- IFX Design tools



#### **Revision History**

IMTA65R020M2H

#### Revision 2024-05-13, Rev. 2.1

#### **Previous Revision**

Revision	Date	Subjects (major changes since last revision)
2.0	2024-04-19	Release of final
2.1	2024-05-13	Updated diagram axis max. and min. values.

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